

Notice of References Cited	Application/Control No. 09/784,352	Applicant(s)/Patent Under Reexamination HEUER, JOERG	
	Examiner Chongshan Chen	Art Unit 2172	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,233,578	05-2001	Machihara et al.	707/10
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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